### Cell phone: (336) 255-5257 E-mail: garyyugu@yahoo.com

# GARY YU GU

## **OBJECTIVE**

Mechanical Engineer in FEA, structural analysis, and electronics packaging

## **KEY QUALIFICATIONS**

- **Six years** of **industry** experience including mechanical engineer, stress analyst, and packaging engineer.
- **Ten years** of **FEA** experiences including static, dynamic, thermo-mechanical, creep, fatigue, drop, contact, fracture, heat transfer, and structural analyses.
- **Ph.D.** in **Solid Mechanics** with in-depth knowledge of microelectronics packaging, MEMS, thin film, and thermally sprayed coating.
- Expertise in **DOE** (design of experiment), **drop test**, and **nano-indentation**.
- Proficiency in FEA software ANSYS, ABAQUS, LS-Dyna, and APDL/macro.
- Proficiency in SDRC-IDEAS and comprehensive parametric modeling.
- Hand on experience on **JMP**, **Fe-Safe**, ProE, AutoCAD, and UNIX systems.
- Self-motivated, highly organized, good written and verbal communication skills.

### WORK EXPERIENCE

2004/5-present RF Micro Devices Inc

Greensboro, NC

## Sr. Packaging Engineer

- Mechanical modeling and FEA in support of the development of flip-chip,
   WLCSP, wire bond, LGA, BGA, and AlN/GaN packages.
- **Drop test** simulation and **DOE** for board-level and device-level drop reliability.
- Thermo-mechanical analysis for stacked die and embedded die packages.
- Modeling support for via cracking, die cracking, solder bridging, interface delamination, and solder fatigue life (creep) estimation.
- Cap structure optimization to protect **SAW filter** and **MEMS switch**.

2003–2004 NSF-MRSEC Thermal Spray Center SUNY Stony Brook, NY **Research Engineer** 

- **FEA** in support of the **design optimization** of pores thermal barrier coatings to protect gas turbine components from high temperature and impact loads.
- **Modal dynamic** and **stiffness analysis** of precision motion systems.
- **High-acceleration dynamic** analysis and mechanical design for a high-stiffness piezoelectric energy supplier for missile excitation.

2002 Summer Symbol Technologies Inc.

Holtsville, NY

## Mechanical Engineer - Intern

Drop and shock simulations/analyses of Symbol's handheld computers
(entire housing with internal assemblies) in support of the prototype design.

2000-2001 Computational Mechanics Lab SUNY at Stony Brook, NY **Consulting Work** 

- Multi-scale (global-local) finite element simulation, 3D fracture analysis, and fatigue life estimation for BGA flip-chip packages.
- **Nano/micro-indentations** for nondestructive mechanical characterization of anisotropic and inhomogeneous **thin films/coatings**.
- Multi-step FEA to reduce the **residual stress** in torque sensor fabrication.
- 3D comprehensive modeling for the **failure jackscrew** (on Alaska Airlines) under critical **friction/wear-out** (for NTSB, ntsb.org).

1992–1995 Dalian Design Ins. of Mechanical & Electronic Tech. China **Mechanical/Stress Engineer** 

- Finite element programming for **structural analysis** of 3D frame and truss.
- Structural design/analysis for major, hanging, and supporting steel structures
  of two 1000-ton cold storage units.
- **Structural design** and **stress analysis** for a 42kg/24hrs ice machine with internal pumping and refrigeration systems.

#### **EDUCATION**

1998–2003 Mechanical Engineering, State Univ. of New York at Stony Brook.

■ Ph.D. Major: Solid Mechanics Minor: Mechanical Design

1995–1998 Institute of Mechanics Chinese Academy of Science, China

M.S. Major: Mechanical Engineering

1988–1992 Mechanical Engineering Dalian University of Technology, China

**B.S.** Major: **Engineering Mechanics** 

## HONORS, AWARDS, AND ACTIVITIES

- Presenter on 2006 IEEE-ECTC and 2005 IMAPS conference.
- Best paper award, Society of Experimental Mechanics Symposium, May 2002.
- Member of ASME, IMAPS, & SigmaXI, an honorary scientific research society.
- **Fellowship** (Research Assistant), Dept. of Mechanical Engineering, State Univ. of New York at Stony Brook, 1998-2003.

## **PUBLICATIONS**

- Three (first author) **journal papers**.
- Three semi-annual and two final technical reports.
- Seven **conference** papers including four **technical presentations**.

Details available upon request.

### REFERENCE

Available upon request.